

Quad 2-Line to 1-Line Data Selector/Multiplexers

These are data selector/multiplexers which select a 4-bit word from one of two sources via the control of a common select input (\bar{A}/B). A separate strobe input (\bar{G}) is provided. The '157 presents true data whereas the '158 presents inverted data at the outputs.

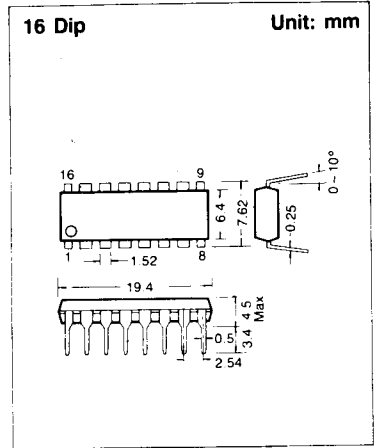
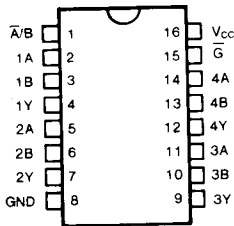
These devices provide speeds and drive capability equivalent to their ALSTTL counterparts and yet maintain CMOS power levels. The input and output voltage levels allow direct interface with TTL, NMOS and CMOS devices without any external components.

All inputs and outputs are protected from damage due to static discharge by internal diode clamps to V_{CC} and ground.

FEATURES

- Function, pin-out, speed and drive compatibility with 54/74ALS logic family
- Low power consumption characteristic of CMOS
- High-Drive-Current outputs:
 $I_{OL} = 8 \text{ mA} @ V_{OL} = 0.5\text{V}$
- Inputs and outputs interface directly with TTL, NMOS and CMOS devices
- Wide operating voltage range: 4.5V to 5.5V
- Characterized for operation over industrial and military temperature ranges:
 KS74AHCT: -40°C to $+85^{\circ}\text{C}$
 KS54AHCT: -55°C to $+125^{\circ}\text{C}$

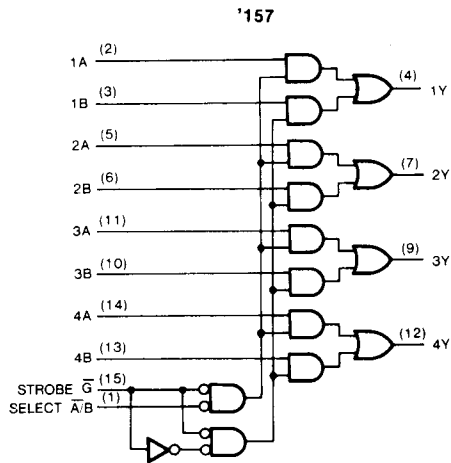
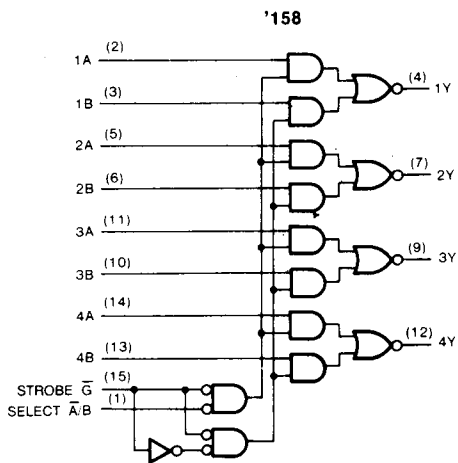
PIN CONFIGURATION



FUNCTION TABLE

Inputs		Output Y			
Strobe \bar{G}	Select \bar{A}/B	Data		'157	'158
		A	B		
H	X	X	X	L	H
L	L	L	X	L	H
L	L	H	X	H	L
L	H	X	L	L	H
L	H	X	H	H	L

LOGIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS*

Characteristic	Symbol	Ratings	Unit
Supply Voltage Range	V_{CC}	-0.5 to +7.0	V
DC Input Diode Current ($V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$)	I_{IK}	± 20	mA
DC Output Diode Current ($V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$)	I_{OK}	± 20	mA
Continuous Output Current Per Pin ($-0.5V < V_O < V_{CC} + 0.5V$)	I_O	± 35	mA
Continuous Current Through V_{CC} or GND pins		± 125	mA
Power Dissipation Per Package	P_d^\dagger	500	mW
Storage Temperature Range	T_{stg}	-65 to +150	°C

* Absolute Maximum Ratings are those values beyond which permanent damage to the device may occur. These are stress ratings only and functional operation of the device at or beyond them is not implied. Long exposure to these conditions may affect device reliability.

† Power Dissipation temperature derating:
 Plastic Package (N): -12mW/°C from 65°C to 85°C
 Ceramic Package (J): -12mW/°C from 100°C to 125°C

RECOMMENDED OPERATING CONDITIONS

Characteristic	Symbol	Value			Unit
		Min	Typ	Max	
Supply Voltage	V _{CC}	4.5	5.0	5.5	V
DC Input & Output Voltages*	V _{IN} , V _{OUT}	0		V _{CC}	V
Operating Temperature Range	KS74AHCT KS54AHCT	T _A	-40 -55	+85 +125	°C °C
Input Rise & Fall Times	t _r , t _f			500	ns

* Unused inputs must always be tied to an appropriate logic voltage level (either V_{CC} or GND)

DC ELECTRICAL CHARACTERISTICS (V_{CC}=5V±10% Unless Otherwise Specified)

Characteristic	Symbol	Test Conditions	T _A = 25°C		KS74AHCT	KS54AHCT	Unit
					T _A = -40°C to +85°C	T _A = -55°C to +125°C	
			Typ	Guaranteed Limits			
Minimum High-Level Input Voltage	V _{IH}			2.0	2.0	2.0	V
Maximum Low-Level Input Voltage	V _{IL}			0.8	0.8	0.8	V
Minimum High-Level Output Voltage	V _{OH}	V _{IN} =V _{IH} or V _{IL} I _O =-20μA I _O =-4mA	V _{CC} 4.2	V _{CC} -0.1 3.98	V _{CC} -0.1 3.84	V _{CC} -0.1 3.7	V
Maximum Low-Level Output Voltage	V _{OL}	V _{IN} =V _{IH} or V _{IL} I _O =20μA I _O =4mA I _O =8mA	0	0.1 0.26 0.39	0.1 0.33 0.5	0.1 0.4	V
Maximum Input Current	I _{IN}	V _{IN} =V _{CC} or GND		±0.1	±1.0	±1.0	μA
Maximum Quiescent Supply Current	I _{CC}	V _{IN} =V _{CC} or GND I _{OUT} =0μA		8.0	80.0	160.0	μA

AC ELECTRICAL CHARACTERISTICS (Input $t_r, t_f \leq 2$ ns), AHCT157, AHCT158

Characteristic	Symbol	Conditions†	$T_A = 25^\circ\text{C}$	KS74AHCT	KS54AHCT	Unit
			$V_{CC} = 5.0\text{V}$	$T_A = -40^\circ\text{C to } +85^\circ\text{C}$ $V_{CC} = 5.0\text{V} \pm 10\%$	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$ $V_{CC} = 5.0\text{V} \pm 10\%$	
			Typ	Guaranteed Limits		
Maximum Propagation Delay, A or B to Y	t_{PLH}		7	11	14	ns
	t_{PHL}		7	11	18	
Maximum Propagation Delay, \bar{A}/\bar{B} to Y	t_{PLH}	$C_L = 50\text{pF}$	9	15	18	ns
	t_{PHL}		9	15	18	
Maximum Propagation Delay, \bar{G} to Y	t_{PLH}		8	14	17	ns
	t_{PHL}		8	14	17	
Maximum Input Capacitance	C_{IN}		5			pF
Power Dissipation Capacitance*	C_{PD}					pF

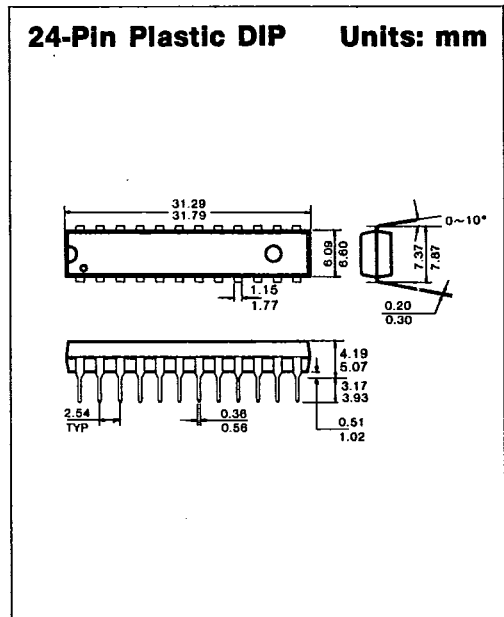
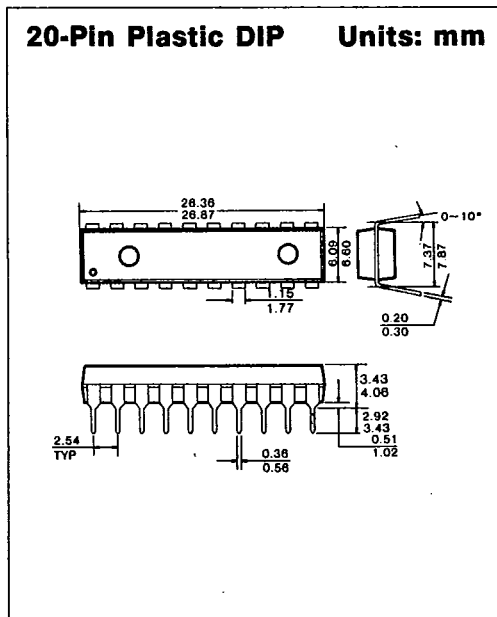
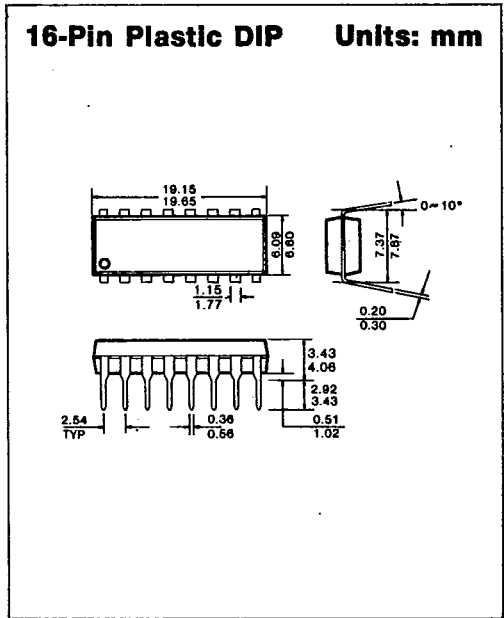
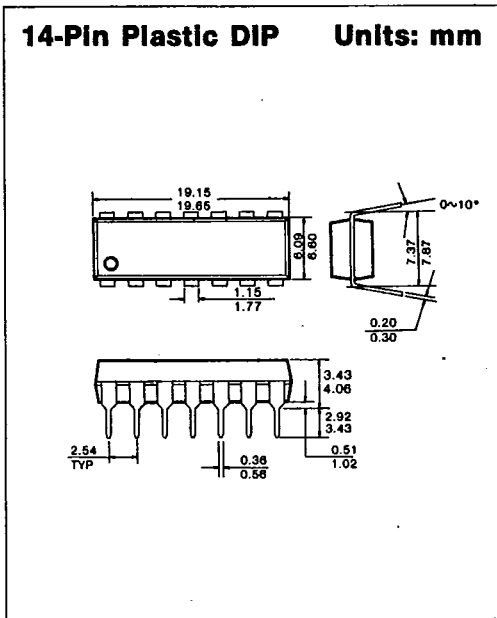
* C_{PD} determines the no-load dynamic power dissipation: $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$.

† For AC switching test circuits and timing waveforms see section 2.

PACKAGE DIMENSIONS

T-90-20

1. PLASTIC PACKAGES



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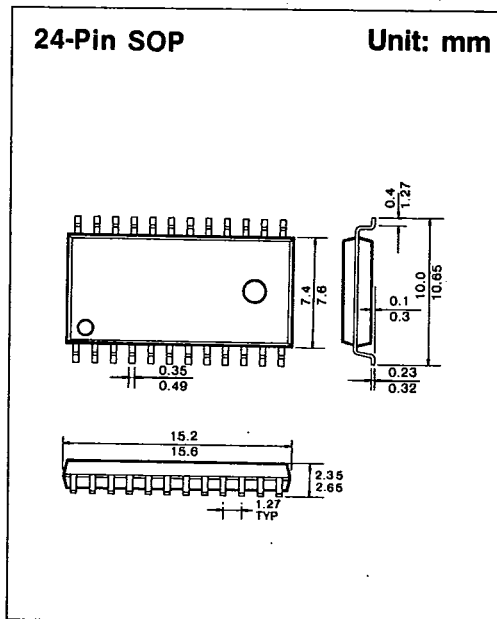
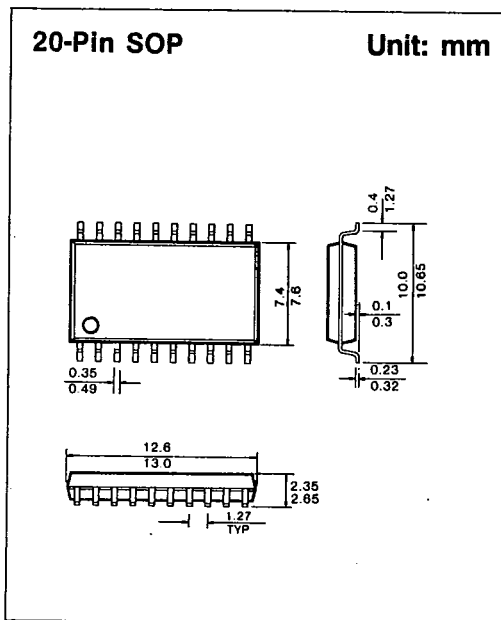
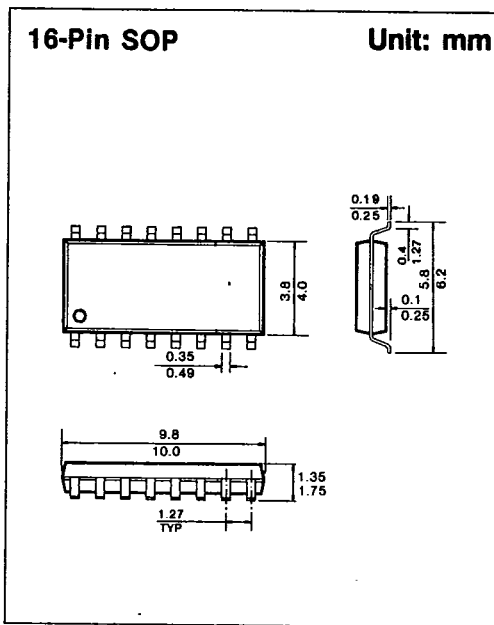
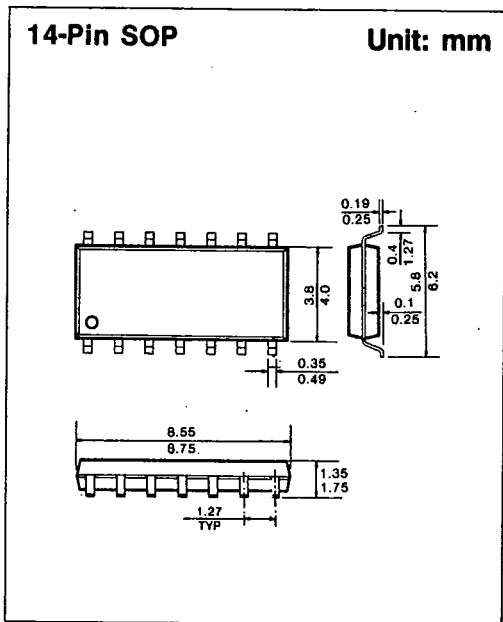
SAMSUNG SEMICONDUCTOR

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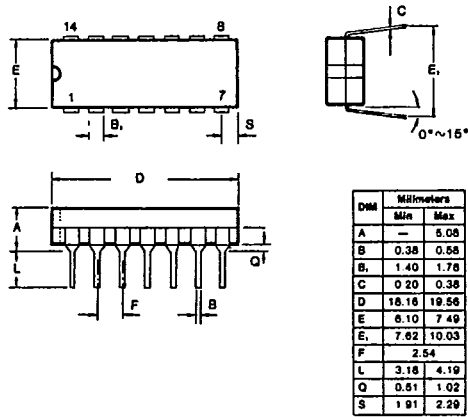


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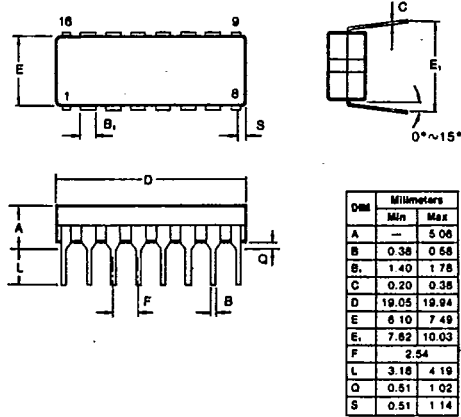
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2. CERAMIC PACKAGES

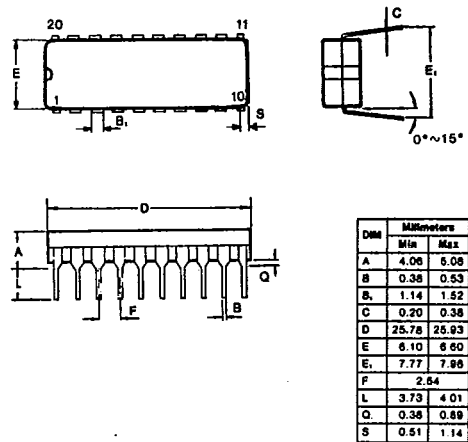
14-Pin Ceramic DIP Units: mm



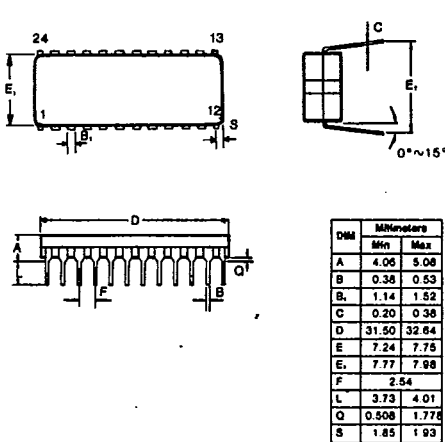
16-Pin Ceramic DIP Units: mm



20-Pin Ceramic DIP Units: mm



24-Pin Ceramic DIP Units: mm



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